

Search Notes

Application/Control No.

10/802,786

Examiner

Thien F. Tran

Applicant(s)/Patent under
Reexamination

HONMA ET AL.

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	295, 296	2/3/2005	TT
257	306, 310	2/3/2005	TT
438	254, 397	2/4/2005	TT

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR